



# STD7NS20

## STD7NS20-1

N-CHANNEL 200V - 0.35Ω - 7A DPAK / IPAK  
MESH OVERLAY™ MOSFET

PRELIMINARY DATA

TYPE	V <sub>DSS</sub>	R <sub>D(on)</sub>	I <sub>D</sub>
STD7NS20	200 V	< 0.40 Ω	7 A
STD7NS20-1	200 V	< 0.40 Ω	7 A

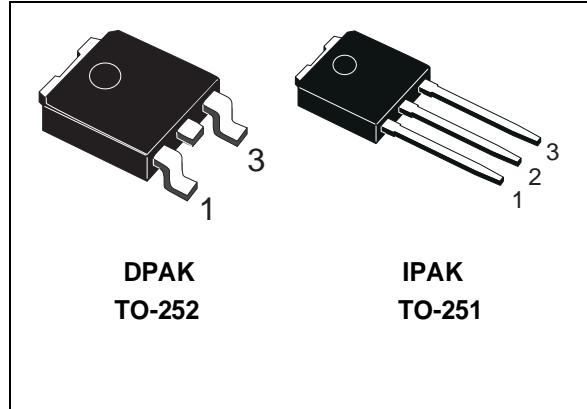
- TYPICAL R<sub>D(on)</sub> = 0.9 Ω
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- VERY LOW INTRINSIC CAPACITANCES
- ADD SUFFIX "T4" FOR ORDERING IN TAPE & REEL

### DESCRIPTION

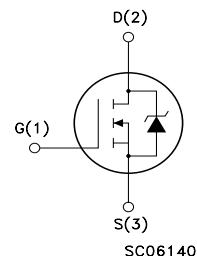
Using the latest high voltage MESH OVERLAY™ process, STMicroelectronics has designed an advanced family of power MOSFETs with outstanding performance. The new patented SStrip layout coupled with the Company's proprietary edge termination structure, makes it suitable in converters for lighting applications.

### APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITH MODE POWER SUPPLIES (SMPS)
- DC-DC CONVERTERS FOR TELECOM, INDUSTRIAL, AND LIGHTING EQUIPMENT



### INTERNAL SCHEMATIC DIAGRAM



### ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source Voltage (V <sub>GS</sub> = 0)	200	V
V <sub>DGR</sub>	Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)	200	V
V <sub>GS</sub>	Gate- source Voltage	± 20	V
I <sub>D</sub>	Drain Current (continuos) at T <sub>C</sub> = 25°C	7	A
I <sub>D</sub>	Drain Current (continuos) at T <sub>C</sub> = 100°C	4.4	A
I <sub>DM</sub> (•)	Drain Current (pulsed)	28	A
P <sub>TOT</sub>	Total Dissipation at T <sub>C</sub> = 25°C	45	W
	Derating Factor	0.37	W/°C
dv/dt (1)	Peak Diode Recovery voltage slope	5	V/ns
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
T <sub>j</sub>	Max. Operating Junction Temperature	150	°C

(•)Pulse width limited by safe operating area

(1) I<sub>SD</sub>≤ 7A, di/dt≤300 A/μs, V<sub>DD</sub>≤ V<sub>(BR)DSS</sub>, T<sub>j</sub>≤T<sub>jMAX</sub>

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### THERMAL DATA

Rthj-case	Thermal Resistance Junction-case Max	2.7	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	100	°C/W
T <sub>l</sub>	Maximum Lead Temperature For Soldering Purpose	275	°C

### AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I <sub>AR</sub>	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T <sub>j</sub> max)	7	A
E <sub>AS</sub>	Single Pulse Avalanche Energy (starting T <sub>j</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 50 V)	60	mJ

### ELECTRICAL CHARACTERISTICS (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED)

OFF

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0	200			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max Rating V <sub>DS</sub> = Max Rating, T <sub>C</sub> = 125 °C			1 10	μA μA
I <sub>GSS</sub>	Gate-body Leakage Current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±20V			±100	nA

### ON (1)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2	3	4	V
R <sub>DS(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 3.5 A		0.35	0.40	Ω

### DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
g <sub>fs</sub> (1)	Forward Transconductance	V <sub>DS</sub> > I <sub>D(on)</sub> × R <sub>DS(on)max</sub> , I <sub>D</sub> = 3.5 A		4		S
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, f = 1 MHz, V <sub>GS</sub> = 0		540		pF
C <sub>oss</sub>	Output Capacitance			90		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			35		pF

**ELECTRICAL CHARACTERISTICS (CONTINUED)****SWITCHING ON**

<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$t_{d(on)}$	Turn-on Delay Time	$V_{DD} = 100 \text{ V}$ , $I_D = 3.5 \text{ A}$		10		ns
$t_r$	Rise Time	$R_G = 4.7\Omega$ $V_{GS} = 10 \text{ V}$ (see test circuit, Figure 3)		15		ns
$Q_g$	Total Gate Charge	$V_{DD} = 160 \text{ V}$ , $I_D = 18 \text{ A}$ ,		31		nC
$Q_{gs}$	Gate-Source Charge	$V_{GS} = 10 \text{ V}$		7.5		nC
$Q_{gd}$	Gate-Drain Charge			9		nC

**SWITCHING OFF**

<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$t_r(V_{off})$	Off-voltage Rise Time	$V_{clamp} = 160 \text{ V}$ , $I_D = 7 \text{ A}$ ,		12		ns
$t_f$	Fall Time	$R_G = 4.7\Omega$ , $V_{GS} = 10 \text{ V}$		12		ns
$t_c$	Cross-over Time	(see test circuit, Figure 5)		25		ns

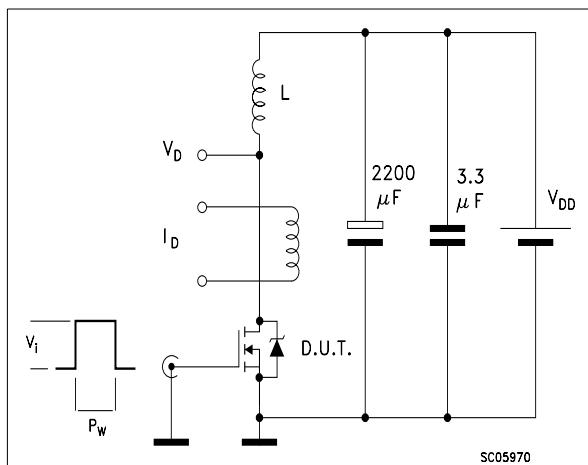
**SOURCE DRAIN DIODE**

<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$I_{SD}$	Source-drain Current				7	A
$I_{SDM}(2)$	Source-drain Current (pulsed)				28	A
$V_{SD}(1)$	Forward On Voltage	$I_{SD} = 7 \text{ A}$ , $V_{GS} = 0$			1.5	V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 7 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$		170		ns
$Q_{rr}$	Reverse Recovery Charge	$V_{DD} = 50 \text{ V}$ , $T_j = 150^\circ\text{C}$		0.95		$\mu\text{C}$
$I_{RRM}$	Reverse Recovery Current	(see test circuit, Figure 5)		11		A

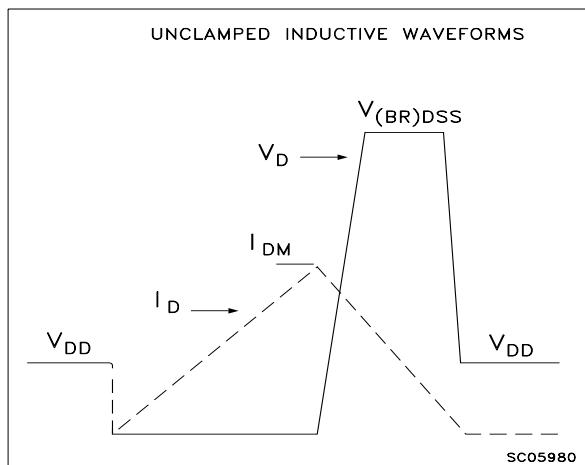
Note: 1. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %.  
2. Pulse width limited by safe operating area.

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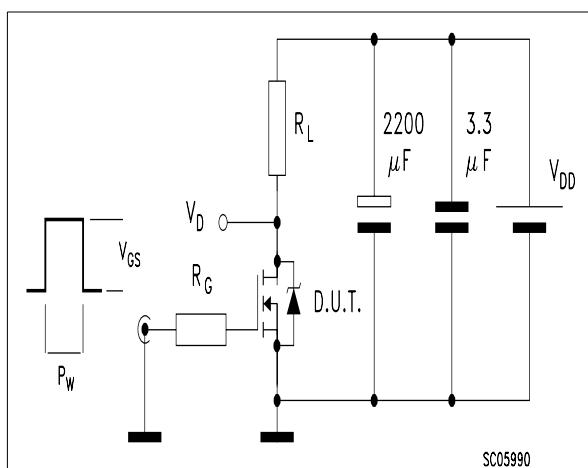
**Fig. 1:** Unclamped Inductive Load Test Circuit



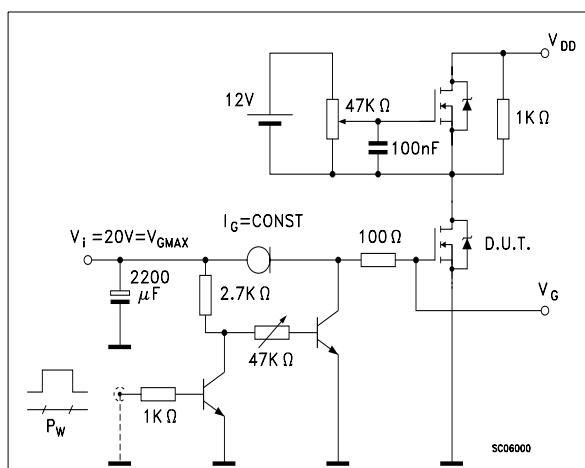
**Fig. 2:** Unclamped Inductive Waveform



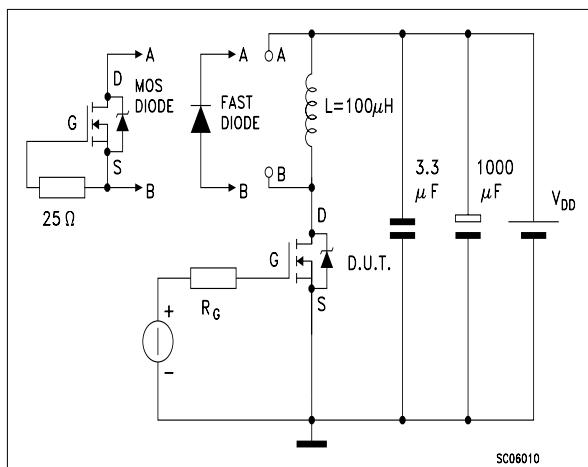
**Fig. 3:** Switching Times Test Circuit For Resistive Load



**Fig. 4:** Gate Charge test Circuit

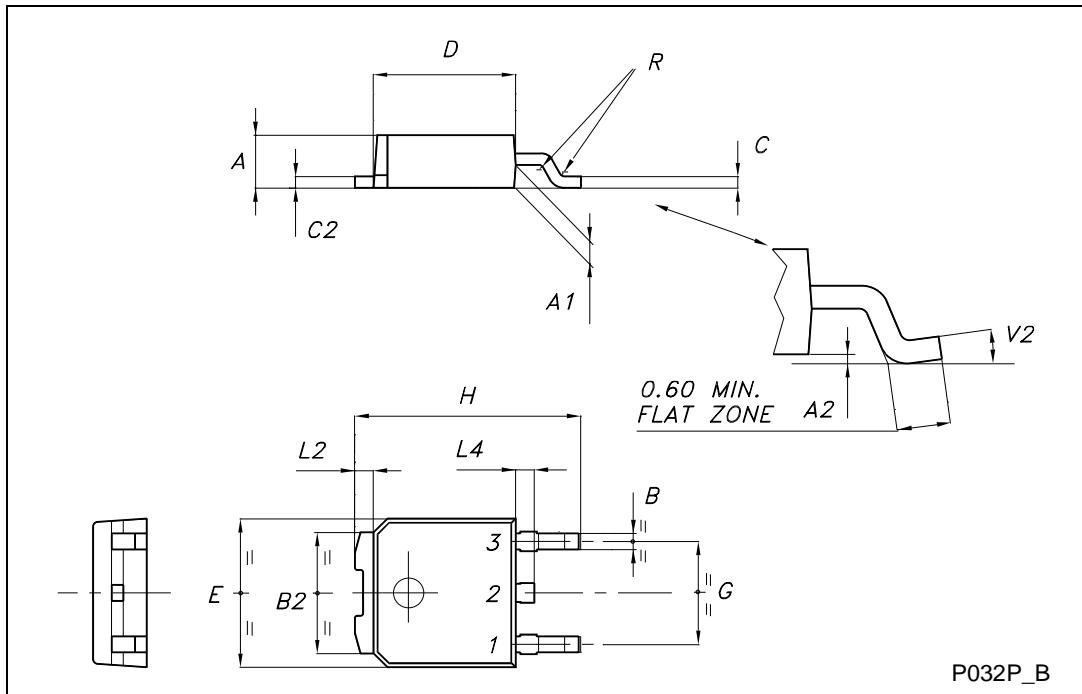


**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Recovery Times



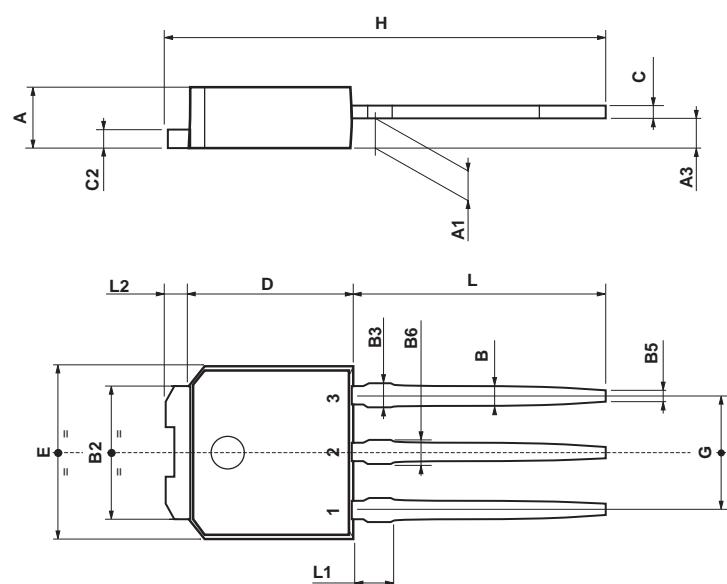
## TO-252 (DPAK) MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.20		2.40	0.087		0.094
A1	0.90		1.10	0.035		0.043
A2	0.03		0.23	0.001		0.009
B	0.64		0.90	0.025		0.035
B2	5.20		5.40	0.204		0.213
C	0.45		0.60	0.018		0.024
C2	0.48		0.60	0.019		0.024
D	6.00		6.20	0.236		0.244
E	6.40		6.60	0.252		0.260
G	4.40		4.60	0.173		0.181
H	9.35		10.10	0.368		0.398
L2		0.8			0.031	
L4	0.60		1.00	0.024		0.039
V2	0°		8°	0°		0°

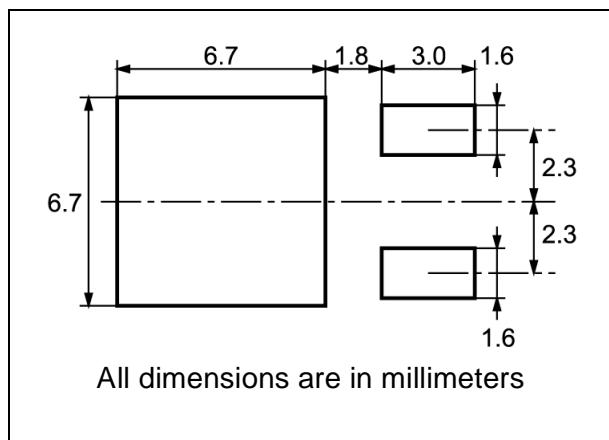
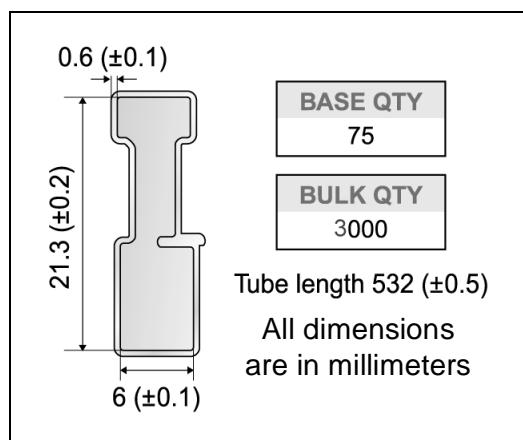
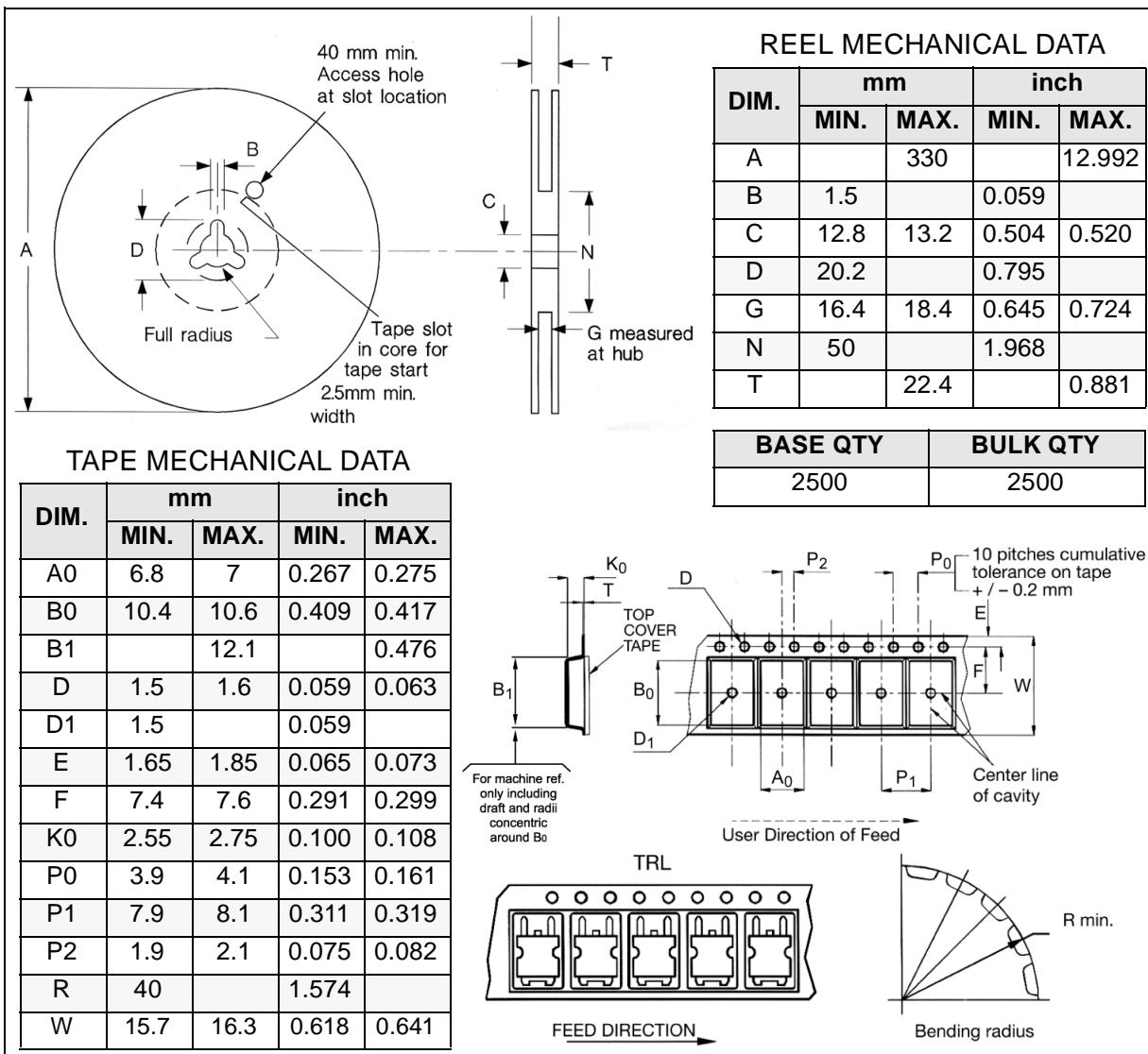


**TO-251 (IPAK) MECHANICAL DATA**

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
B	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
B3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
C	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
E	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
H	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



0068771-E

**DPAK FOOTPRINT****TUBE SHIPMENT (no suffix)\*****TAPE AND REEL SHIPMENT (suffix "T4")\***

\* on sales type



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